Se	earch Notes 		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/798,343	SAITO ET AL.
Examiner	Art Unit
Dinh Q. Nguyen	3752

	SEARCHED				
Class	Subclass	Date	Examiner		
239	585.4				
	533.2				
	900	12/5/05	(VV)		
239	600	12/5/05	WN		
251	129.15	9/25/06	60		
UPDATED	SBARCH	9/25/06	Do N		
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	INTERFERENCE SEARCHED				
CI	ass	Subclass	Date	1	Examiner
23	9	282.1			
\		533.2			
		900			
		600	9/25	06	080
25	ì	129.15	9/25	06	08N

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
(INCLUDING SEARCH	DATE	EXMR	
INTERFORENCE AND EART SEARCHES ATTACHED			
	9/25/06	7/20	
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